Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/809,974	CHEN ET AL.
Examiner	Art Unit

2826

Tuan Quach

	SEAR	CHED			
	SEARCHED				
Class	Subclass	Date	Examiner		
257	295, 310, 368, 410, 411	6/25/2006	TQ		
(update	search)				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
-	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT; USPGPUG; EPO; JPO; DERWENT; IBMTDB) - see search history printout	6/25/2006	TQ
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